



Semileptonic Vector Boson Scattering at the ATLAS Detector and Planar Pixel Sensors for the ATLAS ITk

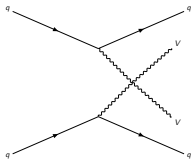
CAT Student Seminar

Tobias Fitschen

2021-05-10

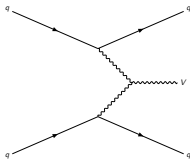
Why study VBS?

Vector Boson Scattering (VBS)



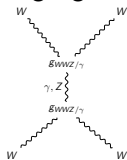
and

Vector Boson Fusion (VBF)

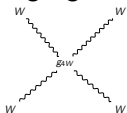


... are sensitive to:

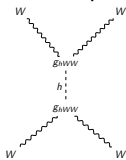
trilinear gauge coupling



quartic gauge coupling



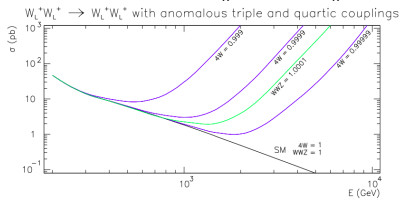
hVV coupling



Each diagram individually is divergent towards high energies

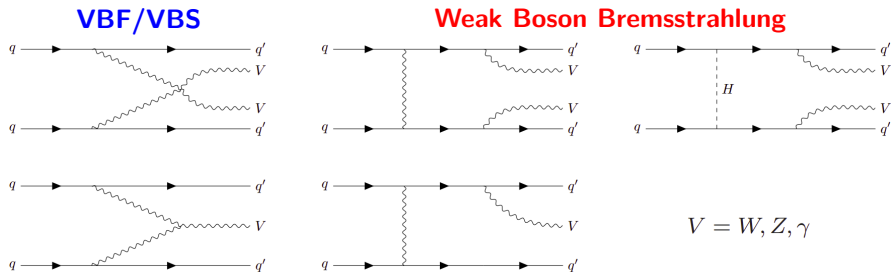
But divergences precisely cancel:

→ Highly sensitive probe for electroweak physics



There is no such thing as a VBS/VBF measurement on its own!

Gauge invariant set of V_{jj} / VV_{jj} diagrams at $\mathcal{O}(\alpha_W^3)$ / $\mathcal{O}(\alpha_W^4)$ tree level:

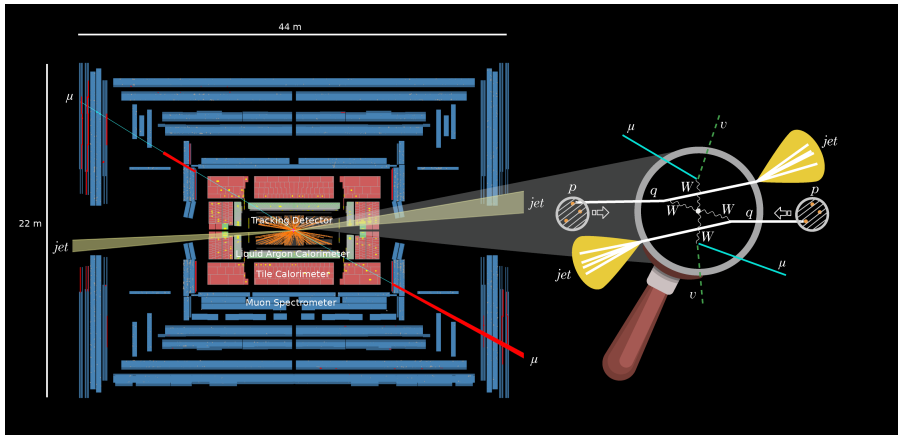


- Negative interference between **VBS/VBF** and **weak boson bremsstrahlung**
- Instead: measure **electroweak (EW) production of V_{jj} and VV_{jj}**
- In this presentation: Semileptonic VV_{jj}

The ATLAS Detector

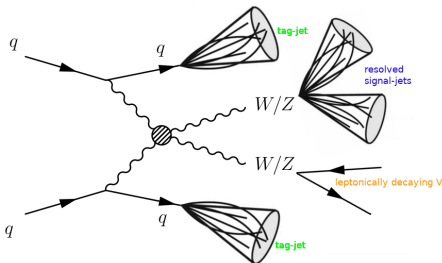
Common experimental signature of VBS events:

- Dijet system jj with large invariant mass m_{jj}
- Different sides/hemispheres of the detector
- Large angular separation



Simplified event display of a fully leptonic VBS candidate event in the ATLAS detector

Semileptonic VBS

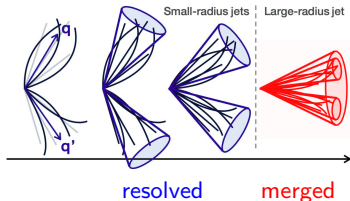


Analysis Goals:

- Measure EW $VVjj$
- Cross-section in fiducial region
→ Differential if possible
- EFT interpretation
→ Search for aQGC
→ Sensitivity in high p_T needed

Final State:

- **2 tagging jets:**
Forward
Opposite Hemispheres
- **1 boson decays hadronically:**
2 $R = 0.4$ signal jets (**resolved**)
or 1 $R = 1.0$ signal jet (**merged**)

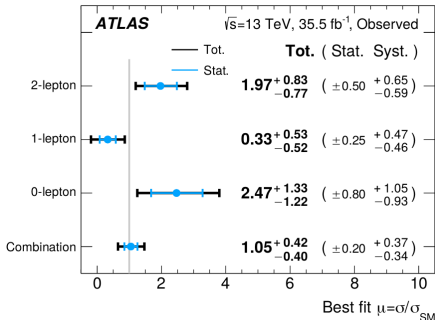


- **1 boson decays leptonically:**
0-lepton: $Z \rightarrow \nu\nu$
1-lepton: $W \rightarrow l\nu$
2-lepton: $Z \rightarrow ll$

Previous Analysis

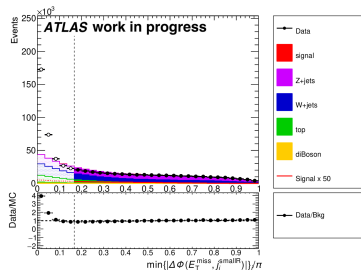
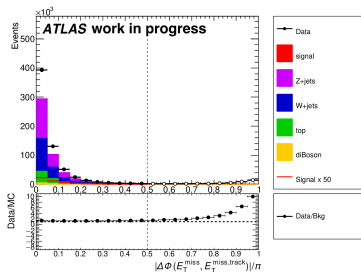
August 2019: Previous Analysis with 35.5 fb^{-1} : [Phys. Rev. D 100, 032007](#)

- Simultaneous max-likelihood fit on BDT outputs in all SRs and CRs
- Cross-section measurement in fiducial region



- Signal strength: $\mu_{\text{EWV}Vjj}^{\text{obs}} = 1.05 \pm 0.20(\text{stat})^{+0.37}_{-0.34}(\text{syst})$
- Significance: $n_{\sigma}^{\text{obs}} = 2.7, n_{\sigma}^{\text{exp}} = 2.5$

0-Lepton Event Selection



Pileup reduction:

- Pileup affects tracker and calorimeters differently
- Exclude events with small $E_T^{\text{miss,track}}$ magnitude
- And with $E_T^{\text{miss,track}}$ in different direction in Φ than E_T^{miss}

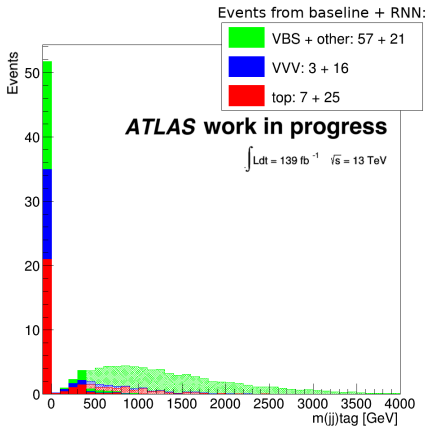
QCD multijet rejection:

- No reliable Monte Carlo for QCD background available
- Must be reduced in data
- QCD events typically only pass E_T^{miss} selection if single mismeasured jet j contributes significantly to E_T^{miss}
- Small distance $\Delta\Phi$ of j to E_T^{miss}

Two approaches for MVA final discriminant:

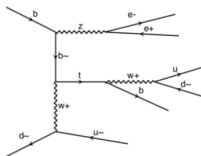
- **Baseline:** Full selection (tag jets & signal jets), multi variate analysis on high level variables
- **RNN approach:** Only signal-, no tag-jet selection, rely on recurrent neural network (RNN) with four-vector input from all jets to distinguish VBS from non-VBS

Signal composition in merged SR

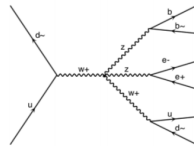


- **Hatched:** Baseline selection
- **Filled:** Additional events from RNN approach (dropping tag-jet selection)
- **Underflow bin:** No two tagging jets reconstructed

Top processes



Triboson processes



→ Most events added by RNN approach do not have reconstructed tag-jets

Summary & Outlook

Semileptonic Vector Boson Scattering at the ATLAS detector

Summary:

- Previous analysis significance: $n_{\sigma}^{\text{obs}} = 2.7$ at 35.5 fb^{-1}
- **New study with 139 fb^{-1} in progress:**
 - Cross section measurement of semileptonic EWK VVjj in fiducial region
 - aQGC study with EFT approach in progress
 - Studies on signal composition (VBS/ non-VBS contributions)
- **Two approaches for MVA final discriminant:**
 - **Baseline:** full selection (tag jets & signal jets) and then BDT or NN
 - **RNN approach:** only signal-, no tag jet selection, then RNN
 - Novel RNN approach must be verified against baseline

Goal:

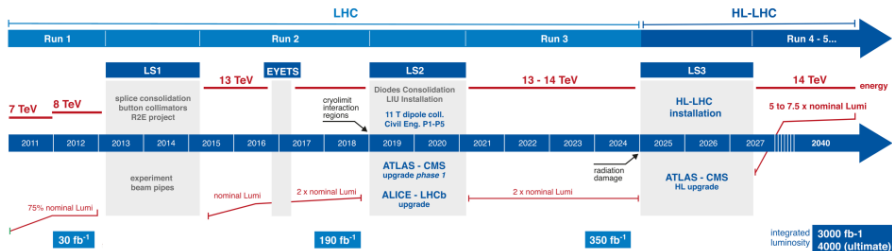
- Obtain 5 sigma observation of the VBS process in semileptonic final state

Part II:
Planar Pixel Sensors for the ATLAS ITk

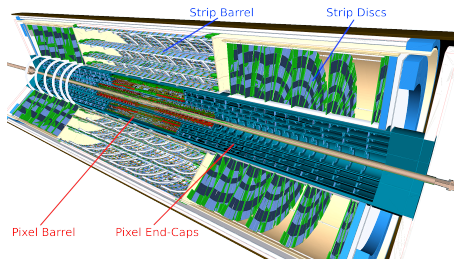
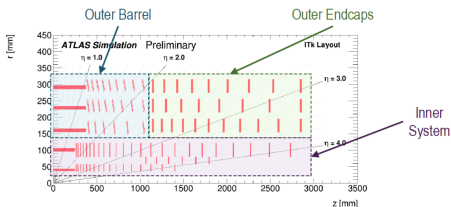
LHC Upgrade



- LHC will be upgraded to High-Luminosity (HL-LHC)
- $\approx 60 \rightarrow 200$ interactions per bunch crossing
- Current inner detector must be upgraded to satisfy new requirements



The ITk Detector



Inner Detector (ID) will be replaced by full-Si Tracker (ITk):

- Has to be able to survive the harsh radiation environment of the HL-LHC
- Increased coverage up to 4η with at least 9 points per track
- Outer Part: Si-strip detectors:
- Inner Part: 5 layers of **Si-pixel detectors** (covered in this talk):
 - Inner layer (L0): 1188 3D sensors ($150 \mu\text{m}$), 34 mm from beam
 - Outer layer (L1): 1200 planar sensors ($100 \mu\text{m}$)
 - Outer barrel and endcap (L2-4): 6816 planar sensors ($150 \mu\text{m}$)

Current pixel system

$\sim 1.9 \text{ m}^2$ of active area
2000 modules
92 Mega-pixels



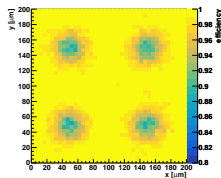
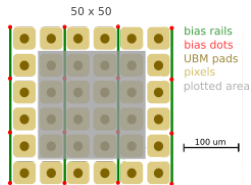
New ITk pixel system

$\sim 13 \text{ m}^2$ of active area
9400 modules
1.4 Giga-pixels

Planar Sensors

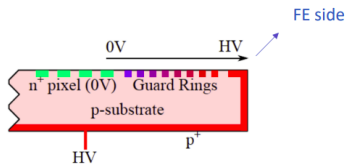
Layers L0-4 equipped with planar sensors:

- Outer layer (L1): 100 μm thickness
- Outer barrel and endcap (L2-4): 150 μm thickness
- Pixel size of 50x50 μm^2
- L2-4 expected to survive full amount of irradiation corresponding to 4000 fb^{-1}
- L1 replaced once ($\rightarrow 2000 \text{fb}^{-1}$)

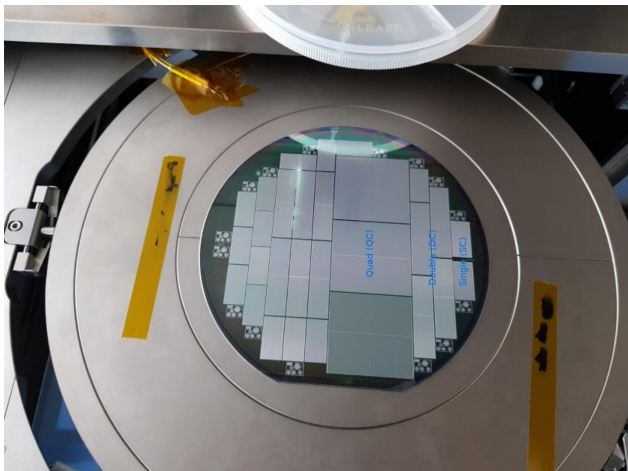


Testing Campaign:

- Visual inspection
- Electrical measurements
- Beam tests



Planar Sensors



Single (SC), Double (DC), and Quad (QC) layouts

- Prototypes from various different foundries tested
- Final modules will all be quads

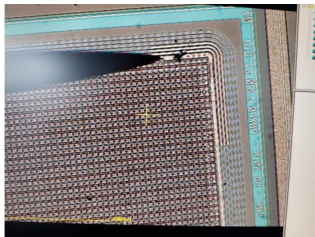
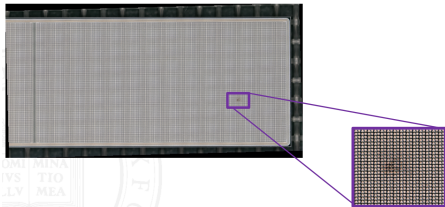
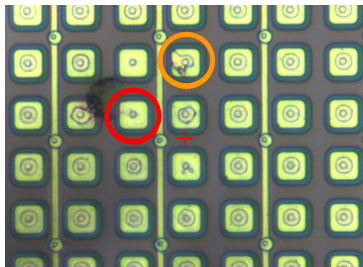
Visual Inspection

Visual inspection requirements:

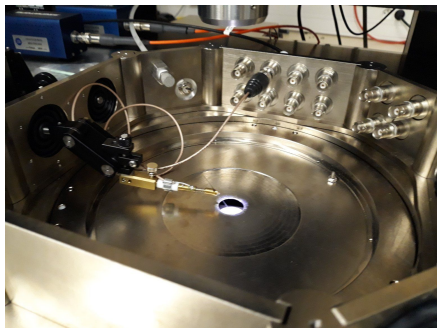
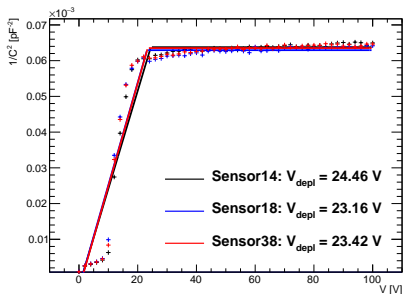
- No stains, residues, scratches
- No chips $> 40 \mu\text{m}$ at edges
- No shorts between pixels
- Thickness and planarity requirements

Results:

- Most sensors show no visual defects, some exceptions



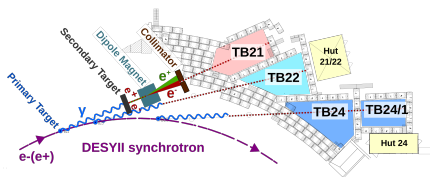
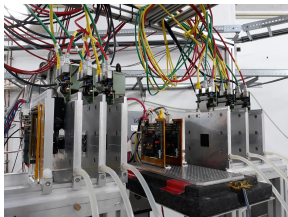
Electrical Characterization



Requirements for Qualification:

- Depletion voltage $V_{\text{dep}} < 100$ V (for $150 \mu\text{m}$ sensors) measured at 1 kHz
- Leakage current $I_{\text{leak}} < 0.75 \mu\text{A}/\text{cm}^2$ at $V_{\text{dep}} + 50$ V
- Variation of leakage current $\Delta I_{\text{leak}} < 25\%$ measured over 48 h
- Breakdown voltage $V_{\text{break}} > V_{\text{dep}} + 70$ V
(V_{break} defined as V at which I_{leak} increases by $> 20\%$ over $\Delta V = 5$ V step)

Beam Tests



Hit efficiency measurements at DESY test beam facility:

- Modules: Planar sensor bump-bonded to RD53 front end chip
- Unirradiated and irradiated to two fluences
- 3 measurement campaigns at DESY: Sep and Nov 2019, Jun 2020
- At least one measurement per vendor per fluence per thickness

Requirements on sensor efficiency:

	Measurement voltage	Fluence	Hit Efficiency
100 and 150 μm thickness	Vdepl+50V	Before irradiation	>98.5%
100 μm thickness	300V	$F=2 \times 10^{15} n_{\text{eq}}/\text{cm}^2$,	>97%
	400V	$F=5 \times 10^{15} n_{\text{eq}}/\text{cm}^2$,	
150 μm thickness	400V	$F=2 \times 10^{15} n_{\text{eq}}/\text{cm}^2$,	>97%
	600V	$F=5 \times 10^{15} n_{\text{eq}}/\text{cm}^2$,	

Planar Pixel Sensors for the ATLAS ITk

ATLAS Inner Detector will be replaced with full-Si ITk:

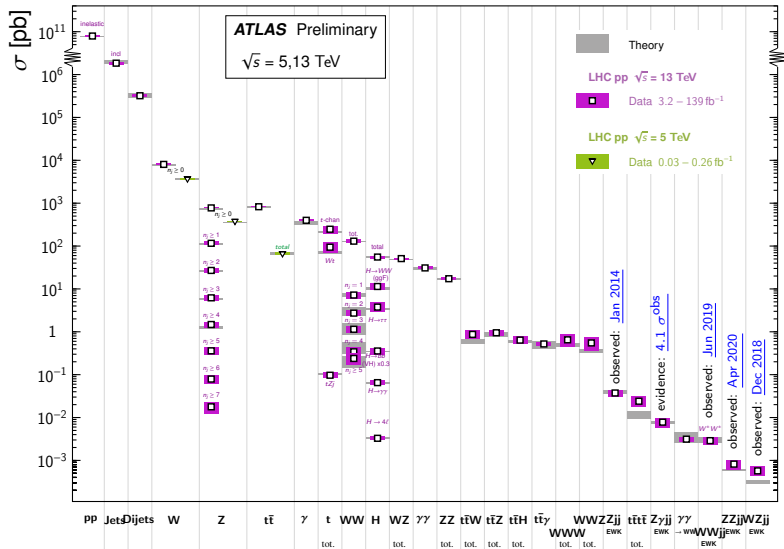
- 1188 3D sensors at high-radiation inner layer
 - Pre-production started
 - $50 \times 50 \mu\text{m}$ and $25 \times 100 \mu\text{m}$ layout
- 8016 planar sensors in outer layers
 - $50 \times 50 \mu\text{m}$ layout
 - Extensive Market Survey to qualify vendors
- Production for both sensor types foreseen for mid 2022 - mid 2024
- QA/QC ongoing during pre-production and production
- Both type of sensors demonstrated necessary requirement for ITk

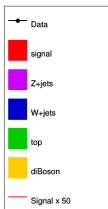
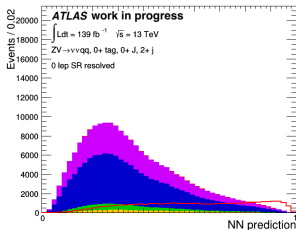
Additional Material

VBS/VBF at ATLAS

Standard Model Production Cross Section Measurements

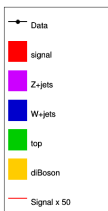
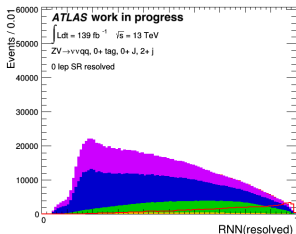
Status: March 2021





Baseline selection MVA:

- Simple feed-forward NN
- Using high-level input variables
- Tag-jet selection for VBS-like events
- But some VBS-like events lost by this

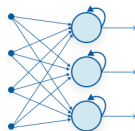


No-tag selection RNN:

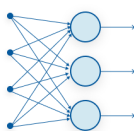
- Dropping selection on j^{tag}
- Full jet four-vectors as inputs in addition to high level variables
- Recurrent architecture (RNN) allows variable input length

Here: Each event has a different number of jets

- Rely on RNN to learn VBS-specific jet configuration



Recurrent Neural Network



Feed-Forward Neural Network

Fiducial Selection:

Object definition:

- ℓ^{good} : μ/e^{truth} with $p_T > 20$ GeV and $|\eta| < 2.5$
- ℓ^{veto} : μ/e^{truth} with $p_T > 7$ GeV and $|\eta| < 2.5$
- $R=4$ jets j : J^{truth} with $(p_T > 20$ GeV and $|\eta| < 2.5)$ or $(p_T > 30$ GeV and $|\eta| < 4.5)$ and $\Delta R(\ell^{\text{good}}) > 0.2$
- $R=1$. jets J : J^{truth} with $p_T > 200$ GeV and $|\eta| < 2$
- b-labeled jet j_b : j with 'HadronConeExclTruthLabelID' = 5
- tag jets: highest-mass (jj) system from all j with $\text{eta}(j_1) * \text{eta}(j_2) < 0$ and not b-labeled
- resolved sig jets $(jj)^{\text{sig}}$: two leading p_T j excluding jj^{tag}
- merged sig jet J^{sig} : leading- p_T J with $\Delta R(j^{\text{tag}}) > 1.4$

Channel selections:

- 0-lepton:
 - $\cancel{E}_T > 200$ GeV
 - $\text{==} 0$ ℓ^{veto}
 - 0 or 2 b-tagged j^{sig} , no other
- 1-lepton:
 - $\cancel{E}_T > 80$ GeV
 - $\text{==} 1$ ℓ^{good}
 - $p_T(\ell^{\text{good}}) > 27$ GeV
 - no b-labeled jets
- 2-lepton:
 - $\text{==} 2$ ℓ^{good}
 - $p_T(\ell_{\text{lead}}^{\text{good}}) > 28$ GeV
 - $p_T(\ell_{\text{sub-lead}}^{\text{good}}) > 20$ GeV
 - 0 or 2 b-labeled j^{sig} , no other

Regime Definitions:

- merged: J^{sig} has $64 < m < 106$ GeV
- resolved: $(jj)^{\text{sig}}$ has $64 < m < 106$ GeV and $p_T(j_{\text{lead}}^{\text{sig}}) > 40$ GeV

Selection order (VBSFidType):

VBSFidType	channel	regime
0	0-lepton	merged
1	0-lepton	resolved
2	1-lepton	merged
3	1-lepton	resolved
4	2-lepton	merged
5	2-lepton	resolved

Tag jet selection (passFidMjjTag):

- p_T of both $j^{\text{tag}} > 30$ GeV
- $m(jj)^{\text{tag}} > 400$ GeV

Number of signal events after various extra selections to reduce non-VBS signal:

baseline selection:

selection	merged HP SR				merged LP SR				resolved SR			
	events	% fid.	% t	% V	events	% fid.	% t	% V	events	% fid.	% t	% V
nominal	68	43	10	4	114	40	12	5	1339	23	28	5
nominal+topMass	58	46	7	4	94	45	8	4	717	31	14	4
nominal+bVetoExcl	62	46	6	4	103	44	8	5	1197	25	22	5
nominal+bVetoExcl+topMass	55	48	5	3	88	47	6	4	683	32	12	4
nominal+bVetoExcl+bVetoSig	56	48	4	4	92	46	5	5	972	29	13	6
nominal+bVetoExcl+bVetoSig+topMass	50	50	4	4	80	49	4	4	588	35	7	5

no-tag selection:

selection	merged HP SR				merged LP SR				resolved SR			
	events	% fid.	% t	% V	events	% fid.	% t	% V	events	% fid.	% t	% V
nominal	130	23	25	15	233	20	28	15	2809	11	43	12
nominal+topMass	100	28	17	13	167	26	19	13	1253	19	27	10
nominal+bVetoExcl	105	28	14	16	185	25	16	16	2197	14	32	23
nominal+bVetoExcl+topMass	86	32	10	13	144	30	12	14	1096	21	31	10
nominal+bVetoExcl+bVetoSig	92	30	10	16	159	27	11	17	1680	17	20	15
nominal+bVetoExcl+bVetoSig+topMass	77	34	7	13	125	32	8	14	894	24	13	11

Extra cuts:

- **topMass:** $m_t > 200$ GeV where m_t : mass of $(jj)^{\text{sig}}$ + additional jet (triplet closest to SM top mass)
- **bVetoExcl:** no R= .4 jet (excl. sig jets) b-tagged
- **bVetoSig:** == 0 or 2 signal jets b-tagged

Fractions:

- % **fid:** Fraction of events passing fiducial selection (resolved + merged combined)
- % **t:** Fraction of events that have a top in the diagram (truth info)

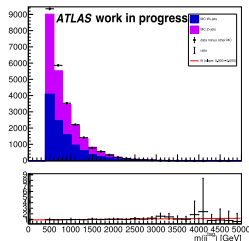
Reweighting

$m(jj)^{\text{tag}}$ reweighting in 0-lepton:

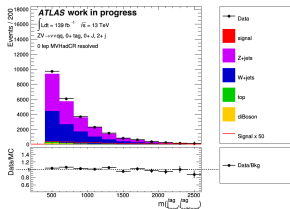
- Well-known mismodeling in Sherpa W/Z+jets samples
- Common issue among VBS/VBF analyses
- $m(jj)^{\text{tag}}$ reweighting derived in 1-lepton/2-lepton (W/Z) CR too strong for 0-lepton
- Independently deriving W and Z reweightings in 0-lepton CR reduces slope substantially

Procedure:

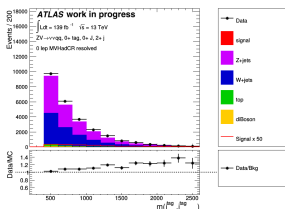
Fit ratio of W/Z+jets to data - all other MC



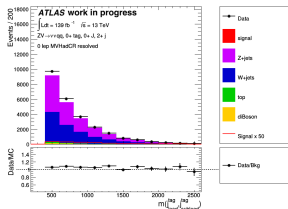
no reweighting



reweighting from 1/2-lep



reweighting from 0-lep

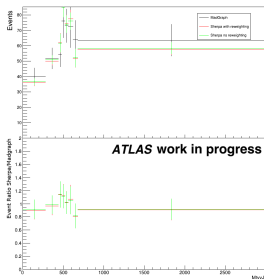


Shape systematics (0-lepton):

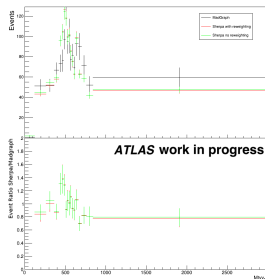
- Shape syst. from ratio of shape in Sherpa (nominal) and MadGraph (syst)
- Normalized to MadGraph
- Rebinned (from right to left: merge bins with < 50 events)
- Two options: With and without $m(jj)$ reweighting in Sherpa

W+jets:

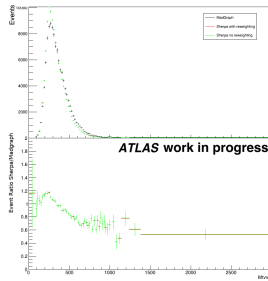
merged HP SR



merged LP SR

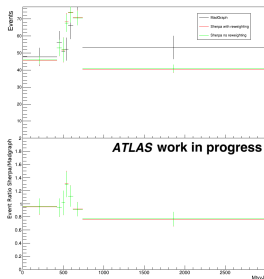


resolved SR

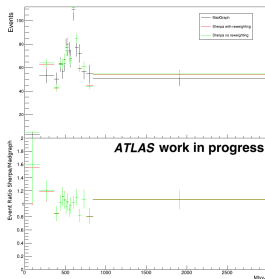


Shape systematics (0-lepton): Z+jets:

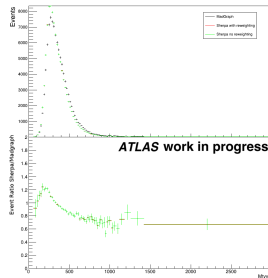
merged HP SR



merged LP SR



resolved SR



Olep Cut Flow

merged LP SR					→	merged LP SR					→	resolved SR				
cut	# MC	signal	background	s/b		cut	# MC	signal	background	s/b		cut	# MC	signal	background	s/b
All	1524036.1	10184.8	1523453.9	0.001		All	1524036.0	10123.3	1523998.3	0.001		All	1524444.9	10064.1	1523442.8	0.001
$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	9347196.5	7421.8	9339774.2	0.001		$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	9347196.1	7301.1	9337426.0	0.001		$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	9320446.9	7096.1	9312448.8	0.001
$N_{\text{sig}}^{\text{MC}} \geq 2$	6294840.3	7400.0	6288080.3	0.001		$N_{\text{sig}}^{\text{MC}} \geq 2$	6293077.0	7347.8	6285725.1	0.001		$N_{\text{sig}}^{\text{MC}} \geq 2$	6287289.2	7313.6	6279207.5	0.001
$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6718390.2	6357.9	6712032.3	0.001		$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6715862.8	6305.7	6709677.1	0.001		$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6707199.0	6271.5	6703927.5	0.001
$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	2772027.2	2981.8	2767281.4	0.001		$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	2769854.8	2931.6	2764928.2	0.001		$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	2762076.0	2987.4	2756178.6	0.001
$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	2044763.9	2074.0	2042089.2	0.001		$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	2062356.5	2022.5	2059734.0	0.001		$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	2050572.8	2068.3	2047668.6	0.001
$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	2035850.4	2056.0	2033984.4	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	2043142.9	2013.7	20413629.2	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	2032359.2	2479.0	2029789.7	0.001
$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1389343.7	1521.0	1386480.8	0.001		$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1387374.3	1468.7	1385280.6	0.001		$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1377950.6	1434.5	1375850.8	0.001
$N_{\text{sig}} \geq 1$	1189538.2	284.9	118253.3	0.002		$N_{\text{sig}} \geq 1$	1161310.2	251.7	115989.1	0.002		$N_{\text{sig}} \geq 1$	1203665.3	1386.0	1202058.9	0.001
$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	1151333.3	274.1	114899.2	0.002		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	112725.8	221.9	112504.0	0.002		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	72307.8	1167.2	721905.7	0.002
$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	1313133.3	274.1	114899.2	0.002		$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	47037.7	145.4	46894.3	0.001		$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	568952.1	1069.0	567983.1	0.002
$ n(\beta) \geq 2.0$	1151333.3	274.1	114899.2	0.002		$ n(\beta) \geq 2.0$	112725.8	221.9	112504.0	0.002		$ n(\beta) \geq 2.0$	568952.1	1069.0	567983.1	0.002
$n(\beta) > 50 \text{ GeV}$	49446.2	195.7	49249.5	0.004		$n(\beta) > 50 \text{ GeV}$	47037.7	145.4	46894.3	0.001		$n(\beta) > 50 \text{ GeV}$	518294.0	1020.8	517213.2	0.002
$\text{DOP}^{\text{FatJetViv}}$	215651.4	1233.3	214386.1	0.006		$\text{DOP}^{\text{FatJetViv}}$	34852.1	114.5	34737.6	0.003		$\text{DOP}^{\text{FatJetViv}}$	387375.8	639.9	386775.8	0.002
$\text{Tagger}^{\text{FatJetViv}}$	5377.2	71.6	5305.7	0.018		$\text{Tagger}^{\text{FatJetViv}}$	17423.9	69.8	17374.2	0.005		$\text{Tagger}^{\text{FatJetViv}}$	262707.3	533.4	262175.9	0.002
$N_{\text{sig}}^{\text{MC}} = 0$	3075.0	54.9	3020.1	0.018		$N_{\text{sig}}^{\text{MC}} = 0$	7942.3	39.1	7903.2	0.005		$N_{\text{sig}}^{\text{MC}} = 0$				
$n(\beta)^{\text{MC}} > 400 \text{ GeV}$	2497.4	52.2	2395.2	0.022		$n(\beta)^{\text{MC}} > 400 \text{ GeV}$	5763.7	48.2	5749.5	0.006		$n(\beta)^{\text{MC}} > 400 \text{ GeV}$				

merged HP CR					→	merged LP CR					→	resolved CR				
cut	# MC	signal	background	s/b		cut	# MC	signal	background	s/b		cut	# MC	signal	background	s/b
All	14971738.0	9566.7	14963172.9	0.001		All	14971738.0	9566.7	14963172.9	0.001		All	14970541.1	9554.9	14961189.3	0.001
$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	14971738.0	9566.7	14963172.9	0.001		$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	14971738.0	9566.7	14963172.9	0.001		$\epsilon_{\text{sig}}^{\text{Trig}} \geq 2$	14970541.1	9554.9	14961189.3	0.001
$N_{\text{sig}}^{\text{MC}} \geq 2$	9024981.9	6782.2	9017799.6	0.001		$N_{\text{sig}}^{\text{MC}} \geq 2$	9025794.0	6802.3	9019916.6	0.001		$N_{\text{sig}}^{\text{MC}} \geq 2$	9025311.6	6803.6	9019520.0	0.001
$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6447963.7	5740.1	6443751.6	0.001		$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6446464.6	5730.9	644204.7	0.001		$P_{\text{T}}^{\text{Lead}} > 30 \text{ GeV}$	6446206.3	5738.2	6441678.0	0.001
$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	1999369.7	2396.0	1997002.7	0.001		$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	1998225.6	2384.8	1996463.8	0.001		$E_{\text{T}}^{\text{Miss}} > 300 \text{ GeV}$	1998383.2	2384.1	1996619.1	0.001
$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	1708195.8	2009.9	1706903.6	0.001		$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	1700322.4	2005.7	1700266.6	0.001		$\epsilon_{\text{sig}}^{\text{Track}} > 30 \text{ GeV}$	1700890.0	2005.0	1700825.0	0.001
$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	1747651.9	1948.1	1746203.8	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	1747651.9	1947.8	1746518.8	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	1746556.4	1946.2	1746729.2	0.001
$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1015243.3	603.1	1014340.1	0.001		$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1014700.2	592.0	1013788.0	0.001		$\min(\Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}})) / \pi < \frac{1}{4}$	1014574.8	603.3	1013365.5	0.001
$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	607416.9	856.0	606907.0	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	606971.8	868.8	606006.0	0.001		$ \Delta\phi(\epsilon_{\text{sig}}^{\text{Track}}, \epsilon_{\text{sig}}^{\text{Track}}) / \pi < \frac{1}{2}$	604382.4	853.4	603929.1	0.001
$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	62179.0	116.4	62089.2	0.002		$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	61835.9	109.2	61826.8	0.002		$P_{\text{T}}^{\text{Lead}} > 200 \text{ GeV}$	499712.2	634.9	499077.3	0.001
$ n(\beta) \geq 2.0$	62179.0	116.4	62089.2	0.002		$ n(\beta) \geq 2.0$	61835.9	109.2	61826.8	0.002		$ n(\beta) \geq 2.0$	505641.8	527.3	505204.5	0.002
$n(\beta) > 50 \text{ GeV}$	24653.7	75.2	24641.4	0.001		$n(\beta) > 50 \text{ GeV}$	24630.6	71.0	24589.6	0.001		$n(\beta) > 50 \text{ GeV}$	305841.8	527.3	305364.5	0.002
$\text{DOP}^{\text{FatJetViv}}$	11440.4	43.5	11435.9	0.004		$\text{DOP}^{\text{FatJetViv}}$	12848.0	59.1	12838.9	0.003		$\text{DOP}^{\text{FatJetViv}}$	139116.1	196.1	138918.1	0.001
$\text{Tagger}^{\text{FatJetViv}}$	6326.8	12.7	6327.1	0.001		$\text{Tagger}^{\text{FatJetViv}}$	7917.8	19.3	7796.5	0.002		$\text{Tagger}^{\text{FatJetViv}}$				
$N_{\text{sig}}^{\text{MC}} = 0$	3558.6	2.5	3556.1	0.002		$N_{\text{sig}}^{\text{MC}} = 0$	3907.9	2.0	3905.9	0.002		$N_{\text{sig}}^{\text{MC}} = 0$	93122.3	69.3	93053.0	0.001
$n(\beta)^{\text{MC}} > 400 \text{ GeV}$	543.1	1.2	546.1	0.002		$n(\beta)^{\text{MC}} > 400 \text{ GeV}$	482.4	0.7	481.7	0.002		$n(\beta)^{\text{MC}} > 400 \text{ GeV}$	24977.0	27.0	24950.0	0.001

Table: Sequential event yields scaled to a luminosity of 139 fb^{-1} in all signal (SR) and control (CR) regions after each consecutive cut.

Olep Cut Flow Raw

merged HP SR					→	merged LP SR					→	resolved SR				
cut	all MC	signal	background	s/b		cut	all MC	signal	background	s/b		cut	all MC	signal	background	s/b
All	130598341.0	1614919.0	12645322.0	0.13		All	130621524.0	1600328.0	126241196.0	0.012		All	126992918.0	1591473.0	126313436.0	0.012
$\epsilon_{\text{Trig}}^{\text{SR}}$	120662741.0	1614919.0	12645322.0	0.13		$\epsilon_{\text{Trig}}^{\text{SR}}$	130621524.0	1600328.0	126241196.0	0.012		$\epsilon_{\text{Trig}}^{\text{SR}}$	126992918.0	1591473.0	126313436.0	0.012
$N_{\text{sig}}^{\text{SR}} \geq 2$	80776623.0	1269189.0	70690734.0	0.016		$N_{\text{sig}}^{\text{SR}} \geq 2$	130621524.0	1600328.0	126241196.0	0.012		$N_{\text{sig}}^{\text{SR}} \geq 2$	126992918.0	1591473.0	126313436.0	0.012
$P_{\text{1}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	794845180.0	1264939.0	70695041.0	0.016		$P_{\text{1}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	794934833.0	1271596.0	70695038.0	0.016		$P_{\text{1}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	797025007.0	1261193.0	70441464.0	0.016
$P_{\text{2}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	60027736.0	1123385.0	59705351.0	0.019		$P_{\text{2}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	600809910.0	1147794.0	59733125.0	0.019		$P_{\text{2}}(N_{\text{sig}}^{\text{SR}}) > 30 \text{ GeV}$	60785213.0	1139899.0	59646174.0	0.019
$\epsilon_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	38979201.0	618326.0	28369375.0	0.022		$\epsilon_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	38929384.0	601235.0	28328149.0	0.021		$\epsilon_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	38782213.0	592180.0	28241246.0	0.021
$\epsilon_{\text{Track}}^{\text{SR}} > 50 \text{ GeV}$	36135279.0	591746.0	25978233.0	0.021		$\epsilon_{\text{Track}}^{\text{SR}} > 50 \text{ GeV}$	36488562.0	542570.0	25946005.0	0.021		$\epsilon_{\text{Track}}^{\text{SR}} > 50 \text{ GeV}$	36382059.0	533702.0	25898154.0	0.021
$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}}) / \pi < \frac{1}{2}$	25111595.0	517173.0	24674387.0	0.022		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}}) / \pi < \frac{1}{2}$	25064723.0	522952.0	24642141.0	0.021		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}}) / \pi < \frac{1}{2}$	24989017.0	513727.0	24482326.0	0.021
$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}})) / \pi < \frac{1}{4}$	14460184.0	347007.0	14151137.0	0.024		$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}})) / \pi < \frac{1}{4}$	14451187.0	332468.0	14118911.0	0.024		$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \epsilon_{\text{Track}}^{\text{SR}})) / \pi < \frac{1}{4}$	14395061.0	328601.0	14021060.0	0.023
$N_{\text{J}} \geq 1$	20989426.0	69004.0	2026064.0	0.035		$N_{\text{J}} \geq 1$	20021231.0	64113.0	1996852.0	0.027		$N_{\text{J}} \geq 1$	123619451.0	1123941.0	12329022.0	0.024
$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \text{J}) / \pi < \frac{1}{2}$	2030223.0	68251.0	1951772.0	0.035		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \text{J}) / \pi < \frac{1}{2}$	1972026.0	53860.0	1919948.0	0.028		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{SR}}, \text{J}) / \pi < \frac{1}{2}$	1479781.0	261206.0	1516773.0	0.032
$P_{\text{1}}(J) > 200 \text{ GeV}$	2030023.0	68251.0	1951772.0	0.035		$P_{\text{1}}(J) > 200 \text{ GeV}$	1972026.0	53860.0	1919948.0	0.028		$P_{\text{1}}(J) > 200 \text{ GeV}$	6947000.0	240336.0	6805664.0	0.030
$ n(J) > 2.0$	2030023.0	68251.0	1951772.0	0.035		$ n(J) > 2.0$	1969382.0	36243.0	1822336.0	0.041		$ n(J) > 2.0$	6346314.0	229704.0	6164633.0	0.038
$n(J) > 50 \text{ GeV}$	903189.0	48927.0	804542.0	0.057		$n(J) > 50 \text{ GeV}$	822245.0	28818.0	595387.0	0.045		$n(J) > 50 \text{ GeV}$	6947000.0	240336.0	6805664.0	0.030
$\text{D3P}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	4130131.0	21141.0	2818170.0	0.082		$\text{D3P}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	1896233.0	173057.0	173057.0	0.303		$\text{D3P}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	6346314.0	229704.0	6164633.0	0.038
$\text{Tagged}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	80322.0	19312.0	60660.0	0.317		$\text{Tagged}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	1154547.0	9639.0	1055211.0	0.094		$\text{Tagged}_{\text{Track}}^{\text{SR}} > 200 \text{ GeV}$	4727912.0	160338.0	4567776.0	0.038
$N_{\text{J}}^{\text{SR}} = 0$	53390.0	15219.0	38131.0	0.399		$N_{\text{J}}^{\text{SR}} = 0$	96769.0	8895.0	86051.0	0.102		$N_{\text{J}}^{\text{SR}} = 0$	4727912.0	160338.0	4567776.0	0.038
$n(J)^{\text{SR}} > 400 \text{ GeV}$	4887.0	14991.0	32226.0	0.453		$n(J)^{\text{SR}} > 400 \text{ GeV}$	96769.0	8895.0	86051.0	0.102		$n(J)^{\text{SR}} > 400 \text{ GeV}$	3743237.0	139798.0	3587059.0	0.038

merged HP CR					→	merged LP CR					→	resolved CR							
cut	data	all MC	signal	background	s/b		cut	data	all MC	signal	background	s/b		cut	data	all MC	signal	background	s/b
All	39175972.0	126037631.0	15646716.0	124767662.0	0.123		All	39175972.0	126037631.0	15646716.0	124767662.0	0.123		All	39175972.0	126037631.0	15646716.0	124767662.0	0.123
$\epsilon_{\text{Trig}}^{\text{CR}}$	39175972.0	126037631.0	15646716.0	124767662.0	0.123		$\epsilon_{\text{Trig}}^{\text{CR}}$	39175972.0	126037631.0	15646716.0	124767662.0	0.123		$\epsilon_{\text{Trig}}^{\text{CR}}$	39175972.0	126037631.0	15646716.0	124767662.0	0.123
$N_{\text{sig}}^{\text{CR}} \geq 2$	22188268.0	76489216.0	1142466.0	74364960.0	0.015		$N_{\text{sig}}^{\text{CR}} \geq 2$	22188268.0	76489216.0	1142466.0	74364960.0	0.015		$N_{\text{sig}}^{\text{CR}} \geq 2$	22188268.0	76489216.0	1142466.0	74364960.0	0.015
$P_{\text{1}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	20066365.0	75948365.0	1142466.0	74853965.0	0.015		$P_{\text{1}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	20066365.0	75948365.0	1142466.0	74853965.0	0.015		$P_{\text{1}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	20066365.0	75948365.0	1142466.0	74853965.0	0.015
$P_{\text{2}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	5636182.0	57606856.0	1002141.0	56604715.0	0.018		$P_{\text{2}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	5636182.0	57606856.0	1002141.0	56604715.0	0.018		$P_{\text{2}}(N_{\text{sig}}^{\text{CR}}) > 30 \text{ GeV}$	5636182.0	57606856.0	1002141.0	56604715.0	0.018
$\epsilon_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	1949132.0	53199231.0	65532.0	53133799.0	0.019		$\epsilon_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	1949132.0	53199231.0	65532.0	53133799.0	0.019		$\epsilon_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	1949132.0	53199231.0	65532.0	53133799.0	0.019
$\epsilon_{\text{Track}}^{\text{CR}} > 50 \text{ GeV}$	1714554.0	32668981.0	366664.0	32302316.0	0.018		$\epsilon_{\text{Track}}^{\text{CR}} > 50 \text{ GeV}$	1714554.0	32668981.0	366664.0	32302316.0	0.018		$\epsilon_{\text{Track}}^{\text{CR}} > 50 \text{ GeV}$	1714554.0	32668981.0	366664.0	32302316.0	0.018
$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}}) / \pi < \frac{1}{2}$	1506333.0	23194665.0	376069.0	22817596.0	0.018		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}}) / \pi < \frac{1}{2}$	1506333.0	23194665.0	376069.0	22817596.0	0.018		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}}) / \pi < \frac{1}{2}$	1506333.0	23194665.0	376069.0	22817596.0	0.018
$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}})) / \pi < \frac{1}{4}$	1043817.0	10618264.0	186693.0	10431570.0	0.018		$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}})) / \pi < \frac{1}{4}$	1043817.0	10618264.0	186693.0	10431570.0	0.018		$\min(\Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \epsilon_{\text{Track}}^{\text{CR}})) / \pi < \frac{1}{4}$	1043817.0	10618264.0	186693.0	10431570.0	0.018
$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \text{J}) / \pi < \frac{1}{2}$	931813.0	95149483.0	189898.0	94960064.0	0.018		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \text{J}) / \pi < \frac{1}{2}$	931813.0	94966164.0	186111.0	94780033.0	0.018		$ \Delta\phi(\epsilon_{\text{Track}}^{\text{CR}}, \text{J}) / \pi < \frac{1}{2}$	942494.0	6797983.0	137651.0	9402279.0	0.018
$P_{\text{1}}(J) > 200 \text{ GeV}$	90623.0	953364.0	26522.0	926842.0	0.027		$P_{\text{1}}(J) > 200 \text{ GeV}$	90623.0	953161.0	24776.0	926665.0	0.027		$P_{\text{1}}(J) > 200 \text{ GeV}$	90623.0	953364.0	26522.0	926842.0	0.027
$ n(J) > 2.0$	90623.0	953364.0	26522.0	926842.0	0.027		$ n(J) > 2.0$	90623.0	953161.0	24776.0	926665.0	0.027		$ n(J) > 2.0$	90623.0	953364.0	26522.0	926842.0	0.027
$n(J) > 50 \text{ GeV}$	21271.0	374681.0	18596.0	366077.0	0.049		$n(J) > 50 \text{ GeV}$	20823.0	368264.0	15719.0	347976.0	0.046		$n(J) > 50 \text{ GeV}$	20806.0	3119088.0	103684.0	3016484.0	0.034
$\text{D3P}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	9762.0	173581.0	9479.0	168703.0	0.059		$\text{D3P}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	9762.0	173767.0	12864.0	162044.0	0.052		$\text{D3P}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	9762.0	173581.0	9479.0	168703.0	0.059
$\text{Tagged}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	16949.0	169491.0	3068.0	166423.0	0.044		$\text{Tagged}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	16949.0	169491.0	3068.0	166423.0	0.044		$\text{Tagged}_{\text{Track}}^{\text{CR}} > 200 \text{ GeV}$	16949.0	169491.0	3068.0	166423.0	0.044
$N_{\text{J}}^{\text{CR}} = 0$	1441.0	38320.0	579.0	37741.0	0.017		$N_{\text{J}}^{\text{CR}} = 0$	1441.0	38320.0	579.0	37741.0	0.017		$N_{\text{J}}^{\text{CR}} = 0$	1441.0	38320.0	579.0	37741.0	0.017
$n(J)^{\text{CR}} > 400 \text{ GeV}$	446.0	17968.0	287.0	17681.0	0.016		$n(J)^{\text{CR}} > 400 \text{ GeV}$	446.0	18091.0	167.0	18026.0	0.017		$n(J)^{\text{CR}} > 400 \text{ GeV}$	446.0	17968.0	287.0	17681.0	0.016

Table: Non-scaled sequential event yields in all signal (SR) and control (CR) regions after each consecutive cut.

Analysis regions:

Regions		Discriminants		
		Merged high-purity	Merged low-purity	Resolved
0-lepton	SR	BDT	BDT	BDT
	V _{jj} CR	m_{jj}^{tag}	m_{jj}^{tag}	m_{jj}^{tag}
1-lepton	SR	BDT	BDT	BDT
	WCR	m_{jj}^{tag}	m_{jj}^{tag}	m_{jj}^{tag}
	TopCR	One bin	One bin	One bin
2-lepton	SR	BDT	BDT	BDT
	ZCR	m_{jj}^{tag}	m_{jj}^{tag}	m_{jj}^{tag}

Baseline MVA inputs:

merged:

Variable	0-lepton	1-lepton	2-lepton
m_{jj}^{tag}	✓	–	✓
$\Delta\eta_{jj}^{\text{tag}}$	–	–	✓
p_T^{tag,j_2}	✓	✓	✓
m_J	✓	–	–
$D_2^{(\beta=1)}$	✓	–	✓
E_T^{miss}	✓	–	–
$\Delta\phi(\vec{E}_T^{\text{miss}}, J)$	✓	–	–
η_ℓ	–	✓	–
$n_{j,\text{track}}$	✓	–	–
ζ_V	–	✓	✓
m_{VV}	–	–	✓
p_T^{VV}	–	–	✓
$m_{VV,jj}$	–	✓	–
$p_T^{VV,jj}$	–	–	✓
w^{tag,j_1}	✓	–	–
w^{tag,j_2}	✓	–	–

resolved:

Variable	0-lepton	1-lepton	2-lepton
m_{jj}^{tag}	✓	–	✓
$\Delta\eta_{jj}^{\text{tag}}$	–	–	✓
p_T^{tag,j_1}	✓	✓	–
p_T^{tag,j_2}	✓	✓	✓
$\Delta\eta_{jj}$	✓	✓	✓
$p_T^{j_1}$	✓	–	–
$p_T^{j_2}$	✓	✓	✓
w^{j_1}	✓	✓	✓
w^{j_2}	✓	✓	✓
$n_{\text{tracks}}^{j_1}$	–	✓	✓
$n_{\text{tracks}}^{j_2}$	–	✓	✓
w^{tag,j_1}	✓	✓	✓
w^{tag,j_2}	✓	✓	✓
$n_{\text{tracks}}^{\text{tag},j_1}$	–	✓	✓
$n_{\text{tracks}}^{\text{tag},j_2}$	–	✓	✓
$n_{j,\text{track}}$	✓	–	✓
$n_{j,\text{extr}}$	✓	–	–
E_T^{miss}	✓	–	–
η_ℓ	–	✓	–
$\Delta R(\ell, \nu)$	–	✓	–
ζ_V	–	✓	✓
m_{VV}	–	–	✓
$m_{VV,jj}$	–	✓	–

Object Definition: Jets

Small-R-jets j :

- EMPFlow
- AntiKt with $R = 0.4$
- $p_T(j) > 20$ GeV

Large-R-jets J :

- LCTopo
- AntiKt with $R = 1.0$
- $p_T(J) > 200$ GeV
- Trimmed with $f_{\text{cut}} = 5.0$,
 $R_{\text{sub}} = 0.2$ (Kt-reclustering)

Track-jets j^{track} :

- From PV0-Tracks
- AntiKt with $R = 0.2$

Tagging Jets $(jj)^{\text{tag}}$:

- dijet small-R-jet system jj with:
- $\Delta\eta(jj) < 0$
- $\max(m_{jj})$

Signal jets $(jj)^{\text{sig}}$:

- dijet small-R-jet system jj with:
- $\min(|m_{W/Z} - m_{jj}|)$
- selected after tagging jets

Signal fat jet J^{sig} :

- leading p_T large-R-jet J
- with $\Delta R(J, j^{\text{tag}}) > 1.4$

B-tagging:

- MV2c10 algorithm
- $\epsilon = 70\%$ working point (in $t\bar{t}$)

Object Reconstruction:

- e: isolated clusters in EMcal matched to ID tracks
 - $E_T > 7$ GeV
 - $|\eta| < 2.47$
 - {loose,medium,tight} id to separate from hadrons
- μ : combined fit from MS and ID
 - $p_T > 7$ GeV
 - $|\eta| < 2.5$
 - {loose,medium,tight} id from #hits in ID and $|\frac{q}{p_{MS}} - \frac{q}{p_{ID}}|$
- $l(e,\mu)$ isolation:
 - from $\sum p_T$ of tracks in p_T -dep. cone around l
- jets: EMPFlow(R=0.4)+LCTopo(R=1.0)
- b-tagging for j at 70% (in $t\bar{t}$), rejection factor: 380(L), 12(C)
- $j(R=0.4)$:
 - $p_T > 20$ GeV at $|\eta| < 2.5$, $p_T > 30$ GeV at $2.5 < |\eta| < 4.5$
 - vertex tagger PU supr. for j with $p_T < 60$ GeV and $|\eta| < 2.5$
- $J(R=1.0)$:
 - $p_T > 200$ GeV, $|\eta| < 2.0$
- $j^{\text{track}}(R=0.2)$ ($\#j^{\text{track}}$ used as BDT input):
 - $p_T > 20$ GeV, $|\eta| < 2.5$
- E_T^{miss} : neg. vectorial sum of $p_T(e,\mu,j)$
- p_T^{miss} : neg. vectorial sum of all good ID tracks assoc. to PV

Overlap Removal:

- j removed if $\Delta R(j, e) < 0.2$
- e removed if $0.2 < \Delta R(j, e) < 0.4$
- j removed if $\Delta R(j, \mu) < 0.2$ and (j has < 3 tracks or small $\Delta E, p(j, \mu)$)
- μ removed if $0.2 < \Delta R(j, \mu) < 0.4$
- J removed if $\Delta R(J, e) < 1.0$
- no overlap removal between $J, j,$ and j^{track}

W/Z tagging (in J):

- p_T dependent requirement on $D_2^{(\beta=1)}$
- must be in p_T dependent window around m_{boson}
- working points of 50% and 80%

Prev. Analysis: 0Lep Event yields:

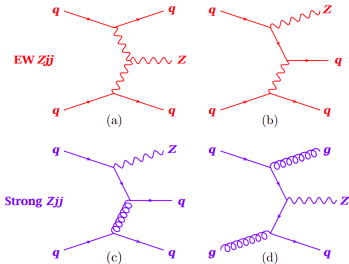
Sample	Resolved	Merged HP	Merged LP	
Background	W + jets	9200 ± 1300	259 ± 27	582 ± 56
	Z + jets	19000 ± 1400	383 ± 29	955 ± 69
	Top quarks	3280 ± 480	277 ± 28	276 ± 32
	Diboson	720 ± 120	69 ± 12	68 ± 14
	Total	32100 ± 2000	988 ± 50	1881 ± 96
Signal	$W(\ell\nu)W(qq')$	56 ± 22	8.0 ± 3.2	5.4 ± 2.2
	$W(\ell\nu)Z(qq)$	12.0 ± 4.7	2.1 ± 0.8	1.6 ± 0.6
	$Z(\nu\nu)W(qq')$	66 ± 25	9.0 ± 3.5	7.4 ± 2.9
	$Z(\nu\nu)Z(qq)$	27 ± 10	5.1 ± 2.0	3.1 ± 1.2
	Total	161 ± 35	24.3 ± 5.2	17.5 ± 3.9
SM	32300 ± 2000	1012 ± 50	1898 ± 96	
Data	32 299	1002	1935	

Prev. Analysis: Uncertainties:

Uncertainty source	σ_μ
Total uncertainty	0.41
Statistical	0.20
Systematic	0.35
Theoretical and modeling uncertainties	
Floating normalizations	0.09
Z + jets	0.13
W + jets	0.09
$t\bar{t}$	0.06
Diboson	0.09
Multijet	0.04
Signal	0.07
MC statistics	0.17
Experimental uncertainties	
Large- R jets	0.08
Small- R jets	0.06
Leptons	0.02
E_T^{miss}	0.04
b -tagging	0.07
Pileup	0.04
Luminosity	0.03

Electroweak Zjj (VBS):

- Leptonic decay: $\rightarrow \ell^+ \ell^- jj$
($\ell = e, \mu$)
- 8 TeV [paper](#) (20.3 fb^{-1}):
5 σ observation
- First 13 TeV [paper](#) (3 fb^{-1}):
Fiducial cross-section
- Current 13 TeV [paper](#) (139 fb^{-1}):



Differential x-sec measurement:

- With respect to 4 observables: $m(jj)$, $|\Delta y(jj)|$, $\Delta\Phi(jj)$, $p_T(\ell\ell)$
- Short term goal: Gives handle on which MC Generator models VBS/VBF most reliably
- Long term goal: Provides input for MC generator improvement

Search for anomalous weak-boson self-interactions:

- EFT approach
- Limits on 4 dim. 6 operators producing anomalous WWZ interactions

Electroweak ZZjj (VBS):

- 13 TeV [paper](#) (139 fb^{-1}):

Final states: $\rightarrow lllljj$ and $ll\nu\nu jj$

Combined: 5.5σ

One of the smallest cross-sections measured in ATLAS!

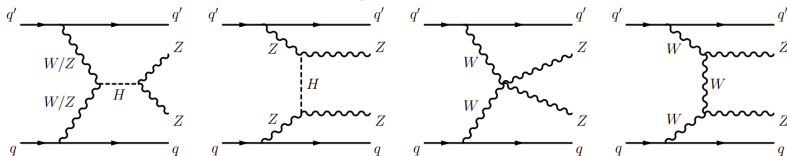
significance of EW Zjj:

	Significance Obs. (Exp.)
$lllljj$	$5.5 (3.9) \sigma$
$ll\nu\nu jj$	$1.2 (1.8) \sigma$
Combined	$5.5 (4.3) \sigma$

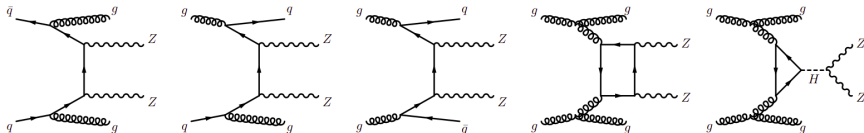
measured cross-section:

$$\sigma_{\text{EW}}^{\text{ZZjj}} = 0.82 \pm 0.21 \text{ fb}$$

EW production:

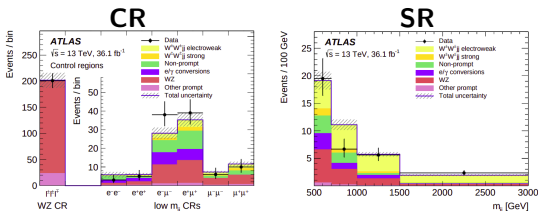


strong production:



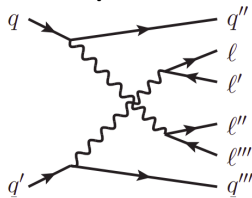
EW WW_{jj} same sign (VBS):

- $W^\pm W^\pm jj$ has largest ratio of EW/QCD cross-section among VBS diboson
- Strong production not the dominant background
- 8 TeV [paper](#) (20.3 fb^{-1}):
Evidence: 4.5σ
- 13 TeV [paper](#) (36.1 fb^{-1}):
observation: 6.5σ
fid. cross-section: $\sigma_{EW}^{W^\pm W^\pm jj} = 2.89 \text{ fb}$

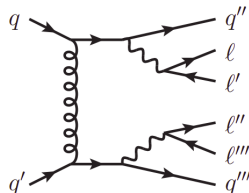


- 6 channels: $e^\pm e^\pm, \mu^\pm \mu^\pm, e^\pm \mu^\pm$
- \Rightarrow 6 SRs ($\times 4$ bins) + 6 m_{jj} CRs + WZ CR

weak production:



strong production:



Non-prompt leptons bkg:

- l from heavy-flavour hadrons
- Jets misidentified as e

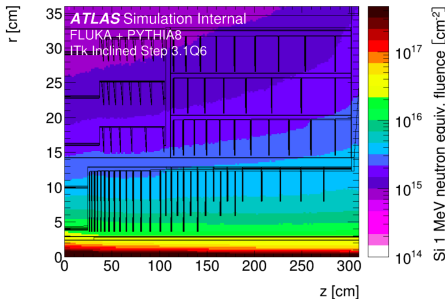
ITk Requirements

Necessary properties:

- Radiation hardness
 - Up to $\approx 2 \times 10^{16} \frac{\text{neq}}{\text{cm}^2}$ (3D at L0)
 - Up to order of 10^7 Gy total ionizing doze (TID)
- Increased pileup
 - Up to 10 times more track density
 - Higher granularity
 - Higher burden on readout

Desired for physics:

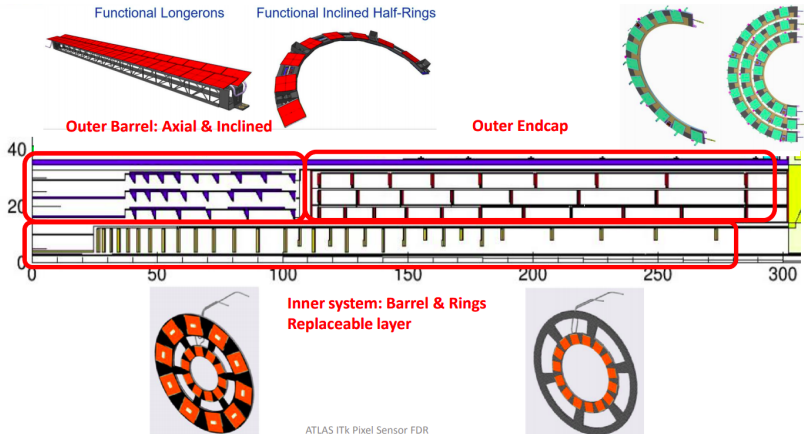
- High spacial resolution
- High single-pixel hit efficiency



Planar sensor radiation requirements:

Layer	max. fluence $n_{\text{eq}}/\text{cm}^2$ (SF=1.5)	max. TID in MGy (SF=1.5)
L1 (@2000fb ⁻¹)	4.1e15	3,4
L2	4.7e15	5,2
L3	3.2e15	2,5
L4	2.4e15	1,4

Support



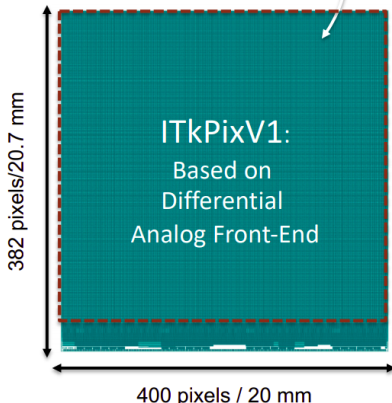
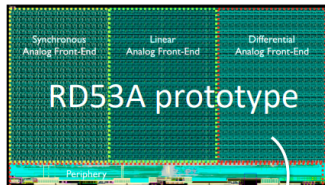
Front End Chip

RD53A prototype:

- Common R&D by ATLAS & CMS
- $50 \times 50 \mu\text{m}$ grid
- Three analog FE

ITkPixV1/2 full size chip:

- Based on differential FE
- 1 MHz trigger rate
- Radiation hard up to $> 5 \text{ MGy}$
($10^{16} \frac{\text{neq}}{\text{cm}^2}$)
- 65 nm technology
- First wafers of V1.1 available
- Final submission of V2 foreseen before end of 2021

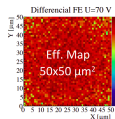
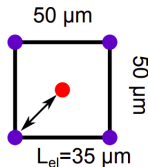


3D Sensors

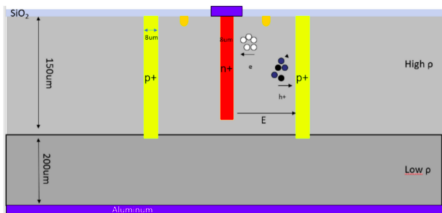
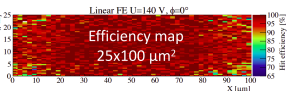
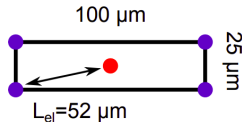
Innermost layer L0 equipped with 3D sensors:

- Final design review (FDR) held 26 Nov 2019
- Proximity to beam requires superior radiation hardness ($10^{16} \frac{\text{neq}}{\text{cm}^2}$)
- L0 replaceable after high irradiation damage
- Triplet module geometry
- Single-side technology (n&p electrodes etched from same side)
- 50×50 (rings) and $25 \times 100 \mu\text{m}^2$ (barrel) pixel size
- $> 97\%$ hit efficiency at 14° incl. ($> 96\%$ perpendicular)

$50 \times 50 \mu\text{m}^2$, 1E



$25 \times 100 \mu\text{m}^2$, 1E

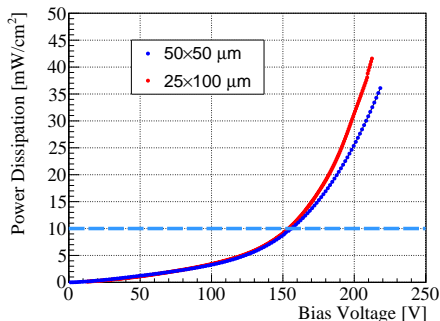


3D Sensors

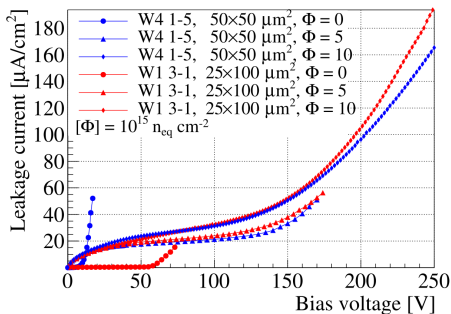
- Low 80 – 140 V bias voltage
- Low power dissipation $< 10 \frac{\text{mW}}{\text{cm}^2}$ (@ $-25 \text{ }^\circ\text{C}$, $10^{16} \frac{\text{neq}}{\text{cm}^2}$)
- More results for 3D sensors in 3D session on Thursday:
 - By [Alessandro Lapertosa](#) on FBK sensors
 - By [Stefano Terzo](#) on CNM sensors

Results for CNM sensors on RD53A:

power dissipation (@ $10^{16} \frac{\text{neq}}{\text{cm}^2}$)



leakage current



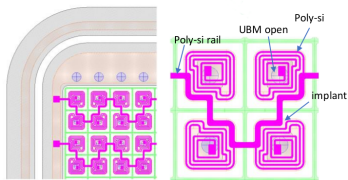
(Nuclear Instruments and Methods in Physics Research Section A, Vol 982)

Bias Structure

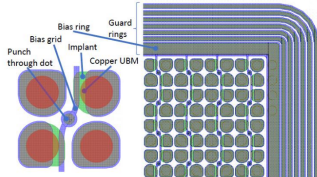
Bias structure allows check of leakage current before flip-chip:

- Several options from different vendors:
 - Poly-silicon bias resistor
 - Higher noise
 - Bias rail with punch-through (PT)
 - Reduced hit efficiency around PT dots
 - No bias structure
 - Needs temporary metal layer until wafer dicing
 - Uniform efficiency
 - No uniform ground in case of disconnected pixel

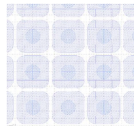
Poly-si bias resistor



PT dot & bias rail

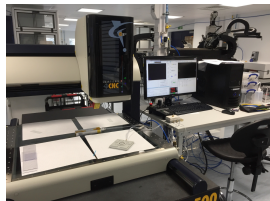
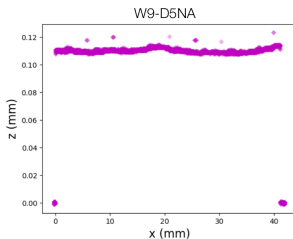
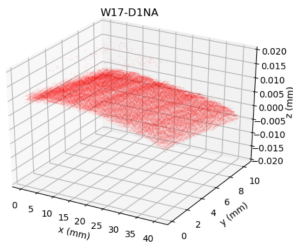


No bias structure



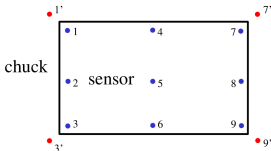
Thickness and Planarity

Some institutes have dedicated setup to perform laser scan



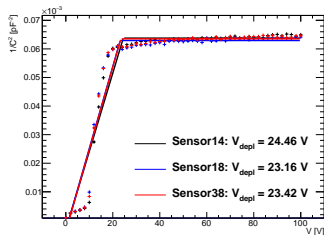
Other institutes: Microscope-focus method:

- Focus on several points on sensor and chuck by adjusting microscope height with fixed focal length
- Local thickness approximated as difference of height h between point on chuck and sensor



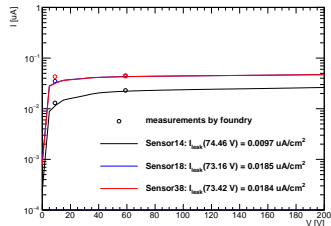
$$\text{thickness} = \langle h_i^{\text{sensor}} - h_i^{\text{chuck}} \rangle_{i \in [1,9]}$$

$$\text{planarity} = \frac{h_4 + h_5 + h_6}{3} - \frac{h_1 + h_2 + h_3 + h_7 + h_8 + h_9}{6}$$



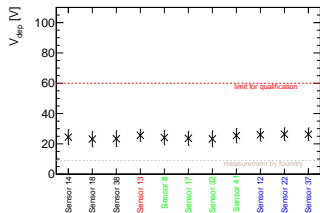
CV measurements:

- Plot $1/C^2$ vs V to calculate V_{depl}
- Perform 2 fits:
 - Constant in fully depleted region
 - Linear rise before
- V_{depl} given by the position of the intersection
- Requirement: $V_{\text{depl}} < 100\text{V}$ (for $150\ \mu\text{m}$)

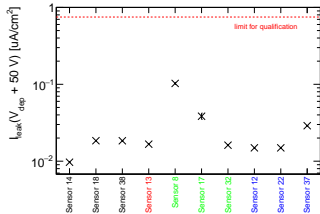


IV measurements:

- Plot I vs V
- Increase by $\Delta I > 20\%$ over $\Delta V = 5\text{V}$ step defined as breakdown
- Requirement: $V_{\text{break}} > V_{\text{depl}} + 70\text{V}$
- Requirement: $I_{\text{leak}}/\text{area} < 0.75\ \mu\text{A}/\text{cm}^2$ at $V_{\text{depl}} + 50\text{V}$



50x50 single 100x25 single 50x50 double 100x25 double



50x50 single 100x25 single 50x50 double 100x25 double

CV measurements:

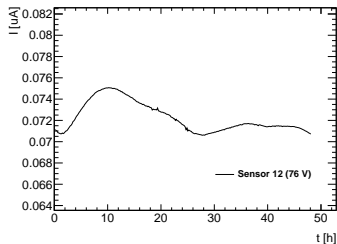
- Plot $1/C^2$ vs V to calculate V_{dep}
- Perform 2 fits:
 - Constant in fully depleted region
 - Linear rise before
- V_{dep} given by the position of the intersection
- Requirement: $V_{dep} < 100 \text{ V}$ (for $150 \mu\text{m}$)

IV measurements:

- Plot I vs V
- Increase by $\Delta I > 20\%$ over $\Delta V = 5 \text{ V}$ step defined as breakdown
- Requirement: $V_{break} > V_{dep} + 70 \text{ V}$
- Requirement: $I_{leak}/\text{area} < 0.75 \mu\text{A}/\text{cm}^2$ at $V_{dep} + 50 \text{ V}$

Leakage Current Stability

It (48 h) $V = V_{\text{dep}} + 50 \text{ V}$



It measurements:

- Plot I at $V = V_{\text{dep}} + 50 \text{ V}$
- Measure for 48 h
- Ensure stable humidity, temperature, and darkness
- Requirement: Variation $\Delta I_{\text{leak}} < 25\%$

Quality Control (QC):

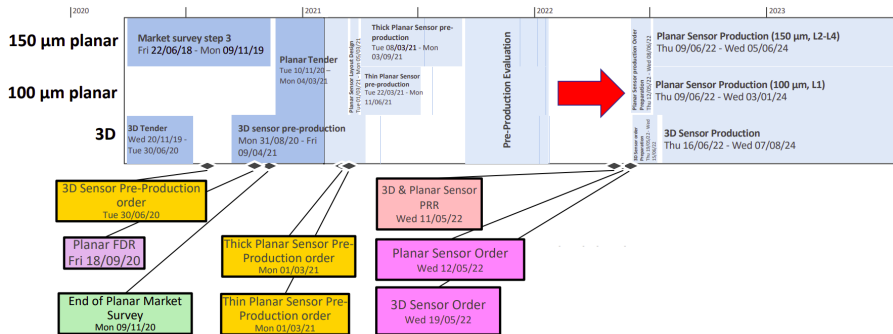
- Identify defects in finished sensors

Quality Assurance (QA):

- Prevent defects in production

	Production stage	Associated QA/QC
Pre-production	Sensor wafer production (sensor vendor)	- IV/CV - Visual inspection - Metrology
	After UBM - Thinning - Backside metallisation and dicing (Hybridisation vendor)	- IV - Metrology - Visual inspection
	On test structures and bare sensors at ITk institutes	- IV/CV/IT - Inter pixel R/C - Irradiations - CCE
	On flip-chipped modules at ITk institutes	- IV/IT - Irradiations - Test-beams
Production	Sensor wafer production (sensor vendor)	- IV/CV - Visual inspection - Metrology
	After UBM, Thinning, Backside metallisation and dicing (Hybridisation vendor)	- IV (?) - Metrology - Visual inspection
	On test structures at ITk institutes	- IV/CV/IT - Inter pixel R/C

ITk Schedule



Planar sensors:

- Pre-prod.: Mar - Sep 2021
- Production: mid 2022 - mid 2024

3D sensors:

- Pre-prod.: Aug 2020 - Apr 2021
- Production: mid 2022 - mid 2024